


<div style="text-align: center;">  <p>LIST OF REFERENCES CITED BY APPLICANT Form PTO-1449 (Use several sheets if necessary)</p> </div>	ATTY. DOCKET NO.:	APPLICATION NO.:
	4717-11600	10/766,207
	APPLICANT:	
	Walter SCHWARZENBACH et al.	
	FILING DATE:	GROUP:
	January 29, 2004	2822


Sheet 1 of 2

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*EXAMINER INITIAL	CITE NO.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
KBD	AA	5,374,564	12/1994	Bruel	437	24	
	AB	6,013,563	1/2000	Henley et al.	438	458	
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							YES	NO
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	AO	EP 1 258 909 A2	11/2002	Europe			X	
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KBD	BA	Chin Teng Lin et al., "Temperature Control Of Rapid Thermal Processing System Using Adaptive Fuzzy Network", Fuzzy Sets and Systems, Vol. 103, pp. 49-65 (1999)
EXAMINER		DATE CONSIDERED
		3/2/2006
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>		